## Issue Classification



Application/Control No.	Applicant(s)/Patent Under Reexamination
08471890	HUFFMAN ET AL.
Examiner	Art Unit

1717

ORIGINAL						INTERNATIONAL CLASSIFICATION									
CLASS SUBCLASS				CLAIMED							NON-CLAIMED				
423 445B			С	0	1	В	31 / 02 (2006.0)								
CROSS REFERENCE(S)					С	0	1	В	31 / 00 (2006.0)						
CLASS	CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)				CK)										
977	735	844	845												

DAH-WEI YUAN

	Claims renumbered in the same order as presented by applicant					СР	'A [5	T.D.	☐ R.1.47						
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	122	17	142	33	159										
2	123	18	143	34	160										
3	124	19	144	35	161										
4	126	20	145	36	162										
5	127	21	146	37	163										
6	130	22	147	38	164										
7	131	23	148	39	165										
8	133	24	149												
9	134	25	154												
10	135	26	154												
1●	136	27	153												
12	137	23	154												
13	138	29	155						1						
14	139	30	156												
15	140	31	157												
16	141	32	158												

	-	Total Claims Allowed:				
(Assistant Examiner)	(Date)	39				
/DAH-WEI YUAN/ Supervisory Patent Examiner.Art Unit 1717	09/08/2011	O.G. Print Claim(s)	O.G. Print Figure			
(Primary Examiner)	(Date)	1	2			